## Notice of References Cited Application/Control No. 10/805,522 Examiner Philip H. Leung Applicant(s)/Patent Under Reexamination KIKUCHI ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0152406	08-2003	Terada et al.	399/328
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